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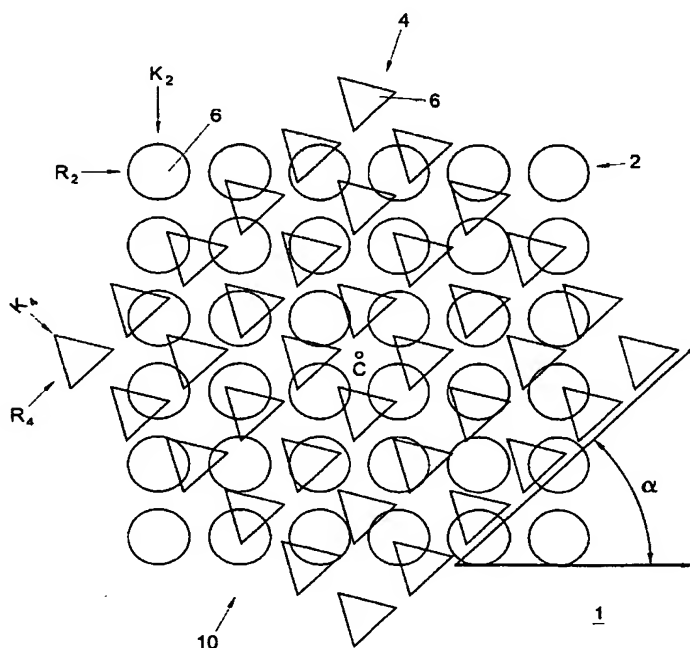
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(54) Title: **METHOD FOR PROVIDING TEXTURES ON PRODUCTS**

(57) Abstract: A method for providing texture on a product part, which comprises providing on the relevant product part a first grid (2), formed from a pattern of rows and columns of deformations of the surface of the relevant product part, placing over the first grid (2) at least a second grid (4), which is comparable to and preferably equal to the first grid (2), the deformations of the second grid (4) at least partly overlapping the deformations of the first grid (2).



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